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(54) **Analog-to-digital converter circuit with selectable input gain**

(57) The circuit includes an analog-to-digital converter (ADC); and one or more switched capacitor amplifier stages connected together in series with a first switched capacitor amplifier stage for receiving the analog input signal, and a last switched capacitor amplifier stage connected to the ADC. Each of the plurality of switched capacitor amplifier stages has a selectable gain to permit control of an overall gain of the analog

input signal upstream of the ADC. The circuit comprises an integrated circuit substrate on which the ADC and the plurality of switched capacitor amplifiers are formed so that the analog-to-digital converter is a monolithic integrated circuit. The circuit also controls the gain of each of the plurality of switched capacitor amplifier stages based upon a digital gain control word. A dock is operatively connected to the ADC and the plurality of switched capacitor amplifier stages.

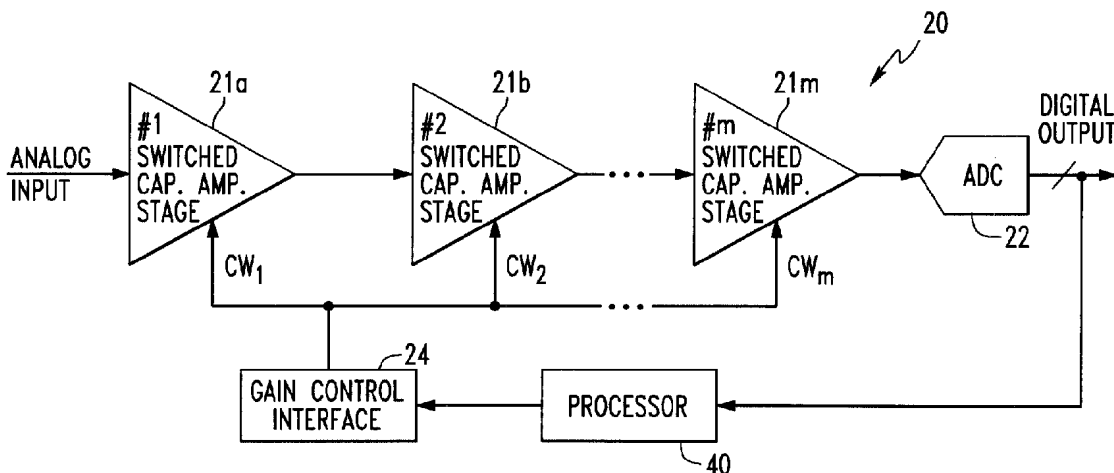


FIG. 4

Description

The present invention relates to the field of electronics, and, more particularly, to an analog-to-digital converter and associated methods.

Analog-to-digital converters (ADCs) are widely used to process electrical signals in many electronic applications. An integrated circuit ADC typically accepts an analog input voltage signal and converts the signal into a digital form as the output. A modern digital communication system, such as for a cellular telephone base station, for example, may often require an ADC with a high resolution of greater than 12 bits, a bandwidth greater than 200 MHz, and low power consumption and low distortion for improved overall system performance.

A pipelined ADC includes a series of subconverter stages with each stage including a flash analog-to-digital converter, a digital-to-analog converter (DAC) and an interstage amplifier connecting the DAC to an adjacent stage. The last stage typically includes only a flash ADC. A multi-step ADC may include one or more similar subconverter stages which are sequentially reused in generating the digital output signal.

The analog signal which is input to an ADC may have different ranges. For example, for communications applications, the analog input signal may cover only a portion of the range of the ADC. In other words, a large portion of the available resolution of the ADC may be wasted. To address such a shortcoming, a prior art circuit 10 as shown in FIG. 1 may be used which includes an integrated circuit programmable gain amplifier (PGA) 11 connected to the input of an ADC chip 12 to thereby control the level of the input analog signal for full resolution by the ADC. As shown, the PGA 11 is also typically a separate integrated circuit from the integrated circuit ADC 12. The specification of U.S. Patent No. 5,144,311 discloses a similar circuit including a portion which comprises an ADC with an optional PGA for adjusting the input level to the ADC.

The gain of a typical PGA 11 as used in the illustrated prior art circuit 10 is either voltage-controlled, or controlled by a digital word including gain setting bits. Of course, such a typical PGA 11 has a limited gain-bandwidth product. Accordingly, as shown in the plots 14, 16 of FIGS. 2 and 3, respectively, the prior art circuit 10 may have a relatively slow response time to change the gain setting. The gain change may be slow as compared to the conversion cycle time of the ADC 12. In other words, the gain cannot be quickly changed, and accuracy is therefore sacrificed.

An object of the present invention is to provide an ADC circuit having input gain control and associated methods which provides fast and accurate changes to the gain, and to provide an ADC circuit having a controllable input gain which is readily manufactured in a compact form providing programmable gain for the signal input.

The present invention includes a circuit for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, said circuit comprising an analog-to-digital converter (ADC), a plurality of switched capacitor amplifier stages connected together in series, a first switched capacitor amplifier stage for receiving the analog input signal and serving as a sample and hold circuit for said ADC, a last switched capacitor amplifier stage connected to said ADC, each of said plurality of switched capacitor amplifier stages having a selectable gain to permit control of an overall gain of the analog input signal upstream of said ADC, and the first switched capacitor amplifier stage is configured for open loop sampling.

The invention also includes a circuit for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, said circuit comprising, an analog-to-digital converter (ADC), at least one switched capacitor amplifier stage operatively connected between the analog input signal and said ADC, said at least one switched capacitor amplifier stage having a selectable gain, and a first one of said at least one switched capacitor amplifier stage is configured for open loop sampling.

The invention furthermore includes a method for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, the method comprising the steps of performing analog-to-digital conversion, providing at least one switched capacitor amplifier stage operatively connected between the analog input signal upstream of the analog-to-digital conversion, said at least one switched capacitor amplifier stage having a selectable gain, selecting a gain of said at least one switched capacitor amplifier, including the step of configuring a first one of the at least one switched capacitor amplifier stage for open loop sampling, in which the step of selecting comprises selecting the gain based upon a clock.

Conveniently, a circuit comprising an analog-to-digital converter (ADC), and one or more switched capacitor amplifier stages connected together in series. A first switched capacitor amplifier stage is for receiving the analog input signal, and a last switched capacitor amplifier stage is connected to the ADC. Moreover, each of the switched capacitor amplifier stages preferably has a selectable gain to permit control of an overall gain of the analog input signal upstream of the ADC. In addition, the first stage may also serve as a sample and hold circuit for the ADC. In one embodiment, the circuit may comprise an integrated circuit substrate on which the ADC and the switched capacitor amplifiers are formed so that the analog-to-digital converter is a monolithic integrated circuit.

The circuit may also comprise gain control interface means for controlling the gain of each of the switched capacitor amplifier stages based upon a digital gain control word. The gain control interface means preferably

comprises latching and aligning means for latching and aligning the digital gain control word to the switched capacitor amplifier stages. A clock is preferably operatively connected to the ADC and the switched capacitor amplifier stages. Accordingly, one important advantage of the present invention is that gain control word changes cause relatively rapid changes in the overall gain.

Each of the switched capacitor amplifiers preferably comprises an amplifier, a plurality of capacitors connectable to at least one input of the amplifier, and at least one switch for selectively connecting the capacitors responsive to the gain control interface means. The capacitors may preferably comprise first and second capacitors having a predetermined ratio to thereby provide corresponding selectable first and second gains. For example, the first and second capacitors may have a common value to thereby provide selectable gains of one or two. In addition, each of the switched capacitor amplifier stages may have a controllable gain of not greater than about two for providing relatively fast settling in view of a finite gain-bandwidth product.

Another important aspect of the present invention is that the first switched capacitor amplifier stage may be configured for open loop sampling. Accordingly, a wide bandwidth can be accommodated by the present invention.

According to yet another important aspect of the invention, the circuit preferably comprises a processor for determining the digital gain control word based upon an output of the ADC. The processor may include ADC range optimizing means for determining the digital gain control word so as to use a relatively large range of the ADC. The processor may also include noise reduction means for generating a digital gain control word to increase the gain of the earlier switched capacitor amplifier stages for reducing noise when an increase in the overall gain is desired. Conversely, the noise reduction means preferably generates the digital gain control word so as to decrease the gain of the latter switched capacitor amplifier stages for reducing noise when a decrease in the overall gain is desired.

Suitably, the circuit may also include offset cancellation means downstream from the ADC. Since changing the stage gains may affect the offset, the processor may also include offset control means cooperating with the offset cancellation means for cancelling the offsets.

Advantageously a method aspect is for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion. The method comprises the steps of: performing the analog-to-digital conversion; providing at least one switched capacitor amplifier stage operatively connected between the analog input signal upstream of the analog-to-digital conversion, the at least one switched capacitor amplifier stage having a selectable gain; and selecting a gain of the at least one switched capacitor amplifier. The step of selecting the gain preferably comprises selecting the gain based upon a clock.

The selecting step may also comprise selecting the gain so as to use a relatively large range for the analog-to-digital conversion and to increase the earlier stages first to reduce noise.

The invention will now be described, by way of example, with reference to the accompanying drawings in which:

FIG. 1 is a schematic diagram of a prior art ADC circuit and including a PGA for controlling an input signal gain to the ADC.

FIG. 2 is a graph of the input signal gain versus time and illustrating the relatively slow increase in input signal gain of the prior art circuit of FIG. 1.

FIG. 3 is a graph of the input signal gain versus time and illustrating the relatively slow decrease in the input signal gain of the prior art circuit of FIG. 1.

FIG. 4 is a block diagram of an ADC circuit and including a controllable input gain circuit in accordance with the present invention.

FIG. 5 is a more detailed schematic block diagram of the circuit as shown in FIG. 4.

FIG. 6 is a graph of an output signal from the circuit as shown in FIG. 4 illustrating a series of on-the-fly gain changes.

Like numbers refer to like elements throughout.

Referring to FIGS. 4 and 5, the circuit **20**, includes an analog-to-digital converter (ADC) **22** and a plurality of switched capacitor amplifier stages **21a-21m** connected together in series. A first switched capacitor amplifier stage **21a** is for receiving the analog input signal V_{in} , and a last switched capacitor amplifier stage **21m** has an output connected to the input of the ADC **22**. Each of the plurality of switched capacitor amplifier stages **21a-21m** has a selectable gain to permit control of an overall gain of the analog input signal upstream of the ADC **22**.

The first stage **21a** may also serve as a sample and hold circuit for the ADC **22**. In slightly different terms, due to the inherent sampling function of a switched capacitor amplifier circuit, the first stage **21a** of the circuit **20** also provides the sample-and-hold function for the ADC **22**.

The circuit **20** also includes gain control interface means **24** for controlling the gain of each of the plurality of switched capacitor amplifier stages **21a-21m** based upon a digital gain control word (CW) with control word bits CW_1-CW_m . Of course, multiple bits may also be used for each stage. The gain control interface means **24** comprises latching and aligning means for latching and aligning the digital gain control word to the plurality of switched capacitor amplifier stages **21a-21m**. A clock **26** is operatively connected to the ADC **22** and the plurality of switched capacitor amplifier stages **21a-21m**. The gain control word should be latched internally to the clock **26** and passed through a digital delay line, not shown, to align the gain setting with the sampled data and thereby making instant gain changes possible. In other words, important advantages of the present inven-

tion are that gain control word changes cause relatively rapid changes in the overall gain, and that the gain changes can be made on-the-fly during operation of the circuit **20**.

As shown in FIG. 4, the switched capacitor amplifier **21a** comprises an amplifier **30**, two capacitors **C1**, **C2** connectable to an input of the amplifier, and a plurality of switching transistors **32-36** for selectively connecting the capacitors responsive to the gain control interface means **24**. The illustrated transistors **32-36** are field-effect transistors controlled through their respective gates.

Open loop sampling is provided with the circuit **20**. The open loop sampling is provided by the arrangement of transistors **34** and **35** with capacitor **C1**. The open loop sampling permits a greater operating bandwidth, such as may become important when operating the circuit **20**, such as, for example, at high input frequencies of 200 MHz and above. The stages **21b-21m** downstream from the first stage **21a** need not be open loop.

Clock signals Φ_1 and Φ_2 are conventional first and second phase clock signals. Clock signal Φ_{1S} is also a conventional derived clock signal. Signals Φ_1' and Φ_1'' are clocked phases controlled by the digital bit CW_1 from the gain control interface means **24**. Only one of the two lines will be activated at the proper time.

For example, to permit selection of either a 0 or 6 dB gain stage, let $C1=C2$ for 0 dB gain with Φ_1' disabled. Then capacitor **C1** samples input voltage while capacitor **C2** samples ground (0 V). During the holding phase the charge stored on capacitor **C1** is transferred to capacitor **C2**, and assuming ideal elements the effective stage gain is:

$$A = \frac{C_1}{C_2} = 1, \text{ which is } 0 \text{ dB}$$

To set the gain to 6 dB, Φ_1'' is disabled. Both capacitors **C1** and **C2** sample the input voltage. During the holding phase, the charge transfer occurs and the effective stage gain is given by:

$$A = \frac{C_1 + C_2}{C_2} = 2, \text{ which is } 6 \text{ dB}$$

The overall selectable gain can be realized by cascading and controlling a number of switched capacitor amplifier stages **21a-21m** as illustrated. For example, four such stages may be a useful configuration, although those of skill in the art will recognize that more or less such amplifier stages may be used in other embodiments. The other switched capacitor amplifier stages **21b-21m** are similarly constructed to the first stage **21a**.

The capacitors **C1** and **C2** may have a predetermined ratio to thereby provide corresponding selectable

first and second gains. For example, the first and second capacitors may have a common value to thereby provide selectable gains of one (0 dB) or two (6 dB). For finer gain control, such as between 0 to 6 dB, the capacitors **C1** and **C2** can be ratioed. Alternately or in addition, the capacitors **C1** and **C2** can be further divided into smaller capacitors with the independently controlled switches to achieve multiple gain steps within the stage. As long as the maximum selectable gain of a stage is less than or equal to the other stage gains, such as for example, 6 db, the op-amp settling time will be less than or equal to the other stages. This precludes any conversion rate penalty as discussed.

Due to the finite gain-bandwidth product of a practically realized op-amp, the maximum selectable stage gain given a fixed settling time requirement is limited. For fast settling, a maximum stage gain of two (6 dB) is typically used. Higher stage gain can be achieved through a trade-off of settling time; hence, the maximum operating clock rate of the amplifier stages **21a-21m** and the ADC **22**. More control bits per stage can be used in such a case.

The circuit **20** comprises a processor **40** for determining the digital gain control word based upon an output of the ADC **22**. The processor **40** may include ADC range optimizing means for determining the digital gain control word so as to use a relatively large range of the ADC. In other words, by controlling the overall gain of the amplifier stages **21a-21m**, the input analog signal may be scaled to take full advantage of the range/resolution of the ADC **22**.

Due to noise concerns, a typical gain change strategy is to increase the gain of earlier stages first to the maximum stage gain, then increase the gain of the succeeding stages in sequence. The noise and offset introduced by later stages are divided by the combined gain of the preceding stages, when referred to the input. Accordingly, the processor **40** may also include noise reduction means for generating a digital gain control word to increase the gain of the earlier switched capacitor amplifier stages for reducing noise when an increase in the overall gain is desired. Conversely, the noise reduction means generates the digital gain control word so as to decrease the gain of the latter switched capacitor amplifier stages for reducing noise when a decrease in the overall gain is desired. In addition, each of the switched capacitor amplifier stages **21a-21m** may have a controllable gain of not greater than about two for providing relatively fast settling in view of a finite gain-bandwidth product.

The circuit **20** may also include offset cancellation means **28** downstream from the ADC **22** (FIG. 5). Since changing the stage gains may affect the offset, the processor **40** may also include offset control means cooperating with the offset cancellation means for cancelling the offsets as the gains are changed.

Turning now to the graph of FIG. 6, operation of the circuit **20** is explained. The output of the ADC **22** respon-

sive to a 5 MHz input signal and sampled at 40 MHz is shown by the plot 42. In the illustrated output plot 42, the overall gain (A) progressively increases in steps from 0 dB to 24 dB in 6 dB increments, thereafter, the gain is changed back to 0 dB. As is readily apparent from the plot 42, the changes in gain occur relatively quickly and can be made on-the-fly.

A method aspect is for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion. The method comprises the steps of: performing analog-to-digital conversion; providing at least one switched capacitor amplifier stage 21a-21m operatively connected between the analog input signal upstream of the analog-to-digital conversion, the at least one switched capacitor amplifier stage having a selectable gain; and selecting a gain of the at least one switched capacitor amplifier. The step of selecting the gain preferably comprises selecting the gain based upon a clock 26. The selecting step may also comprise selecting the gain so as to use a relatively large range for the analog-to-digital conversion, and to increase the earlier stages first to reduce noise as described.

As shown in FIG. 5, the circuit 20 comprises an integrated circuit substrate 29 on which the ADC 22 and the plurality of switched capacitor amplifiers stages 21a-21m are formed so that the circuit is a monolithic integrated circuit. Part or all of the gain control interface means 24 may also be formed on the substrate 29 as would also be readily understood by those skilled in the art. The illustrated processor 40, offset cancellation means 28, and clock 26 may also be included on the integrated circuit substrate 29. In other embodiments, the switched capacitor amplifier stages 21a-21m and the ADC 22 may be individual integrated circuits, or formed from discrete components.

The circuit includes an analog-to-digital converter (ADC); and one or more switched capacitor amplifier stages connected together in series with a first switched capacitor amplifier stage for receiving the analog input signal, and a last switched capacitor amplifier stage connected to the ADC. Each of the plurality of switched capacitor amplifier stages has a selectable gain to permit control of an overall gain of the analog input signal upstream of the ADC. The circuit comprises an integrated circuit substrate on which the ADC and the plurality of switched capacitor amplifiers are formed so that the analog-to-digital converter is a monolithic integrated circuit. The circuit also controls the gain of each of the plurality of switched capacitor amplifier stages based upon a digital gain control word. A clock is operatively connected to the ADC and the plurality of switched capacitor amplifier stages.

Claims

1. A circuit for performing an analog-to-digital conver-

sion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, said circuit comprising an analog-to-digital converter (ADC), a plurality of switched capacitor amplifier stages connected together in series, a first switched capacitor amplifier stage for receiving the analog input signal and serving as a sample and hold circuit for said ADC, a last switched capacitor amplifier stage connected to said ADC, each of said plurality of switched capacitor amplifier stages having a selectable gain to permit control of an overall gain of the analog input signal upstream of said ADC, and the first switched capacitor amplifier stage is configured for open loop sampling.

2. A circuit as claimed in claim 1 including gain control interface means for controlling the gain of each of said plurality of switched capacitor amplifier stages based upon a digital gain control word, in which said gain control interface means comprises latching and aligning means for latching and aligning the digital gain control word to said plurality of switched capacitor amplifier stages.
3. A circuit as claimed in claims 1 or 3 wherein a clock is operatively connected to said ADC and said plurality of switched capacitor amplifier stages so that gain control word changes cause relatively rapid changes in the overall gain based upon said clock.
4. A circuit as claimed in claim 3 wherein each of said switched capacitor amplifiers comprises, an amplifier, a plurality of capacitors connectable to at least one input of said amplifier, at least one switch for selectively connecting each of said plurality of capacitors responsive to said gain control interface means, in which said plurality of capacitors comprise first and second capacitors having a predetermined ratio to thereby provide corresponding selectable first and second gains, also having a common value to provide selectable gains of one and two.
5. A circuit as claimed in any one of claims 1 to 4 wherein a processor for determining the digital gain control word based upon an output of said ADC, in which said processor comprises ADC range optimizing means for determining the digital gain control word so as to use a relatively large range of said ADC, and said processor comprises noise reduction means for generating a digital gain control word to increase the gain of earlier switched capacitor amplifier stages for reducing noise when an increase in the overall gain is desired, and for generating the digital gain control word so as to decrease the gain of latter switched capacitor amplifier stages for reducing noise when a decrease in the overall gain is desired.

6. A circuit as claimed in claim 5 including offset cancellation means downstream from said ADC for cancelling an offset; wherein said processor further comprises offset cancellation control means for controlling said offset cancellation means for cancelling offsets based upon gain changes, including an integrated circuit substrate on which said ADC and said plurality of switched capacitor amplifiers are formed so that said circuit is a monolithic integrated circuit. 5
7. A circuit for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, said circuit comprising, an analog-to-digital converter (ADC), at least one switched capacitor amplifier stage operatively connected between the analog input signal and said ADC, said at least one switched capacitor amplifier stage having a selectable gain, and a first one of said at least one switched capacitor amplifier stage is configured for open loop sampling. 10
8. A circuit as claimed in claim 7 wherein said at least one switched capacitor amplifier stage comprises a plurality of switched capacitor amplifier stages, a first switched capacitor amplifier stage for receiving the analog input signal, a last switched capacitor amplifier stage connected to said ADC, including gain control interface means for controlling the gain of each of said plurality of switched capacitor amplifier stages based upon a digital gain control word, in which said gain control interface means comprises latching and aligning means for latching and aligning the digital gain control word to said plurality of switched capacitor amplifier stages. 15
9. A circuit as claimed in claim 8 wherein a clock is operatively connected to said ADC and said plurality of switched capacitor amplifier stages so that gain control word changes cause relatively rapid changes in the overall gain based upon said clock. 20
10. A circuit as claimed in any one of claims 7 to 9 wherein each of said switched capacitor amplifiers comprises, an amplifier, a plurality of capacitors connectable to at least one input of said amplifier, at least one switch for selectively connecting each of said plurality of capacitors responsive to said gain control interface means, in which said plurality of capacitors comprise first and second capacitors having a predetermined ratio to provide corresponding selectable first and second gains. 25
11. A circuit as claimed in claim 10 wherein said plurality of capacitors comprise first and second capacitors having a common value to provide selectable gains of one and two, including a processor for determining the digital gain control word based upon an output of said ADC, and said processor comprises ADC range optimizing means for determining the digital gain control word so as to use a relatively large range of said ADC. 30
12. A circuit as claimed in claim 11 wherein said processor comprises noise reduction means for generating a digital gain control word to increase the gain of earlier switched capacitor amplifier stages for reducing noise when an increase in the overall gain is desired, and for generating the digital gain control word so as to decrease the gain of latter switched capacitor amplifier stages for reducing noise when a decrease in the overall gain is desired, including offset cancellation means downstream from said ADC for cancelling an offset; and wherein said processor further comprises offset cancellation control means for controlling said offset cancellation means for cancelling offsets based upon gain changes, and comprising an integrated circuit substrate on which said ADC and said plurality of switched capacitor amplifiers are formed so that said circuit is a monolithic integrated circuit. 35
13. A method for performing an analog-to-digital conversion and for controlling a gain of an analog input signal upstream of the analog-to-digital conversion, the method comprising the steps of performing analog-to-digital conversion, providing at least one switched capacitor amplifier stage operatively connected between the analog input signal upstream of the analog-to-digital conversion, said at least one switched capacitor amplifier stage having a selectable gain, selecting a gain of said at least one switched capacitor amplifier, including the step of configuring a first one of the at least one switched capacitor amplifier stage for open loop sampling, in which the step of selecting comprises selecting the gain based upon a clock. 40
14. A method as claimed in claim 13 wherein the step of selecting comprises selecting the gain so as to use a relatively large range for the analog-to-digital conversion, with the step of providing at least one switched capacitor amplifier comprises providing a plurality of switched capacitor amplifiers connected together in series, in which the step of selecting comprises selecting the gains of earlier switched capacitor amplifier stages for reducing noise when an increase in the overall gain is desired, and selecting the gains of latter switched capacitor amplifier stages for reducing noise when a decrease in the overall gain is desired, including the steps of cancelling an offset downstream from the analog-to-digital conversion, and controlling the offset cancelling based upon gain changes. 45

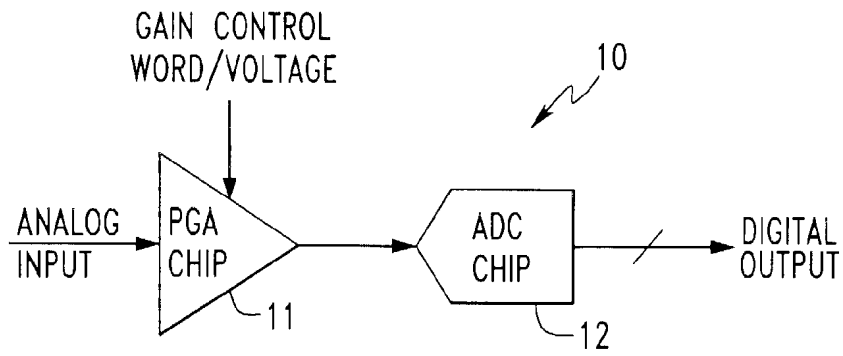


FIG. 1
PRIOR ART

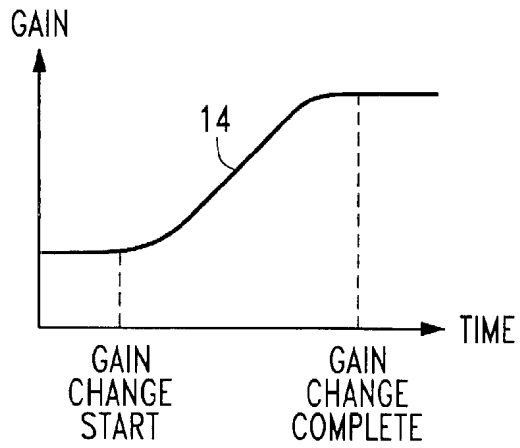


FIG. 2
PRIOR ART

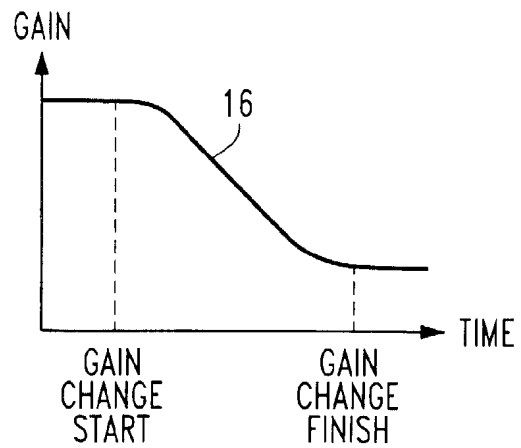
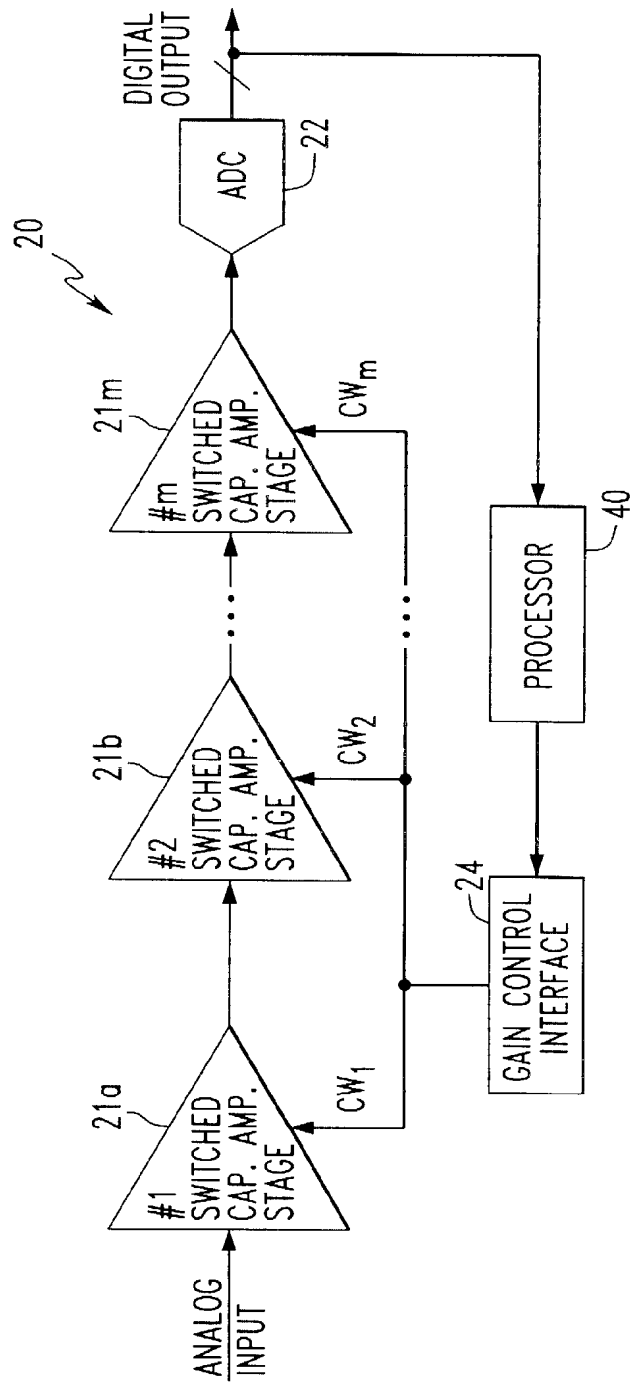


FIG. 3
PRIOR ART

**FIG. 4**

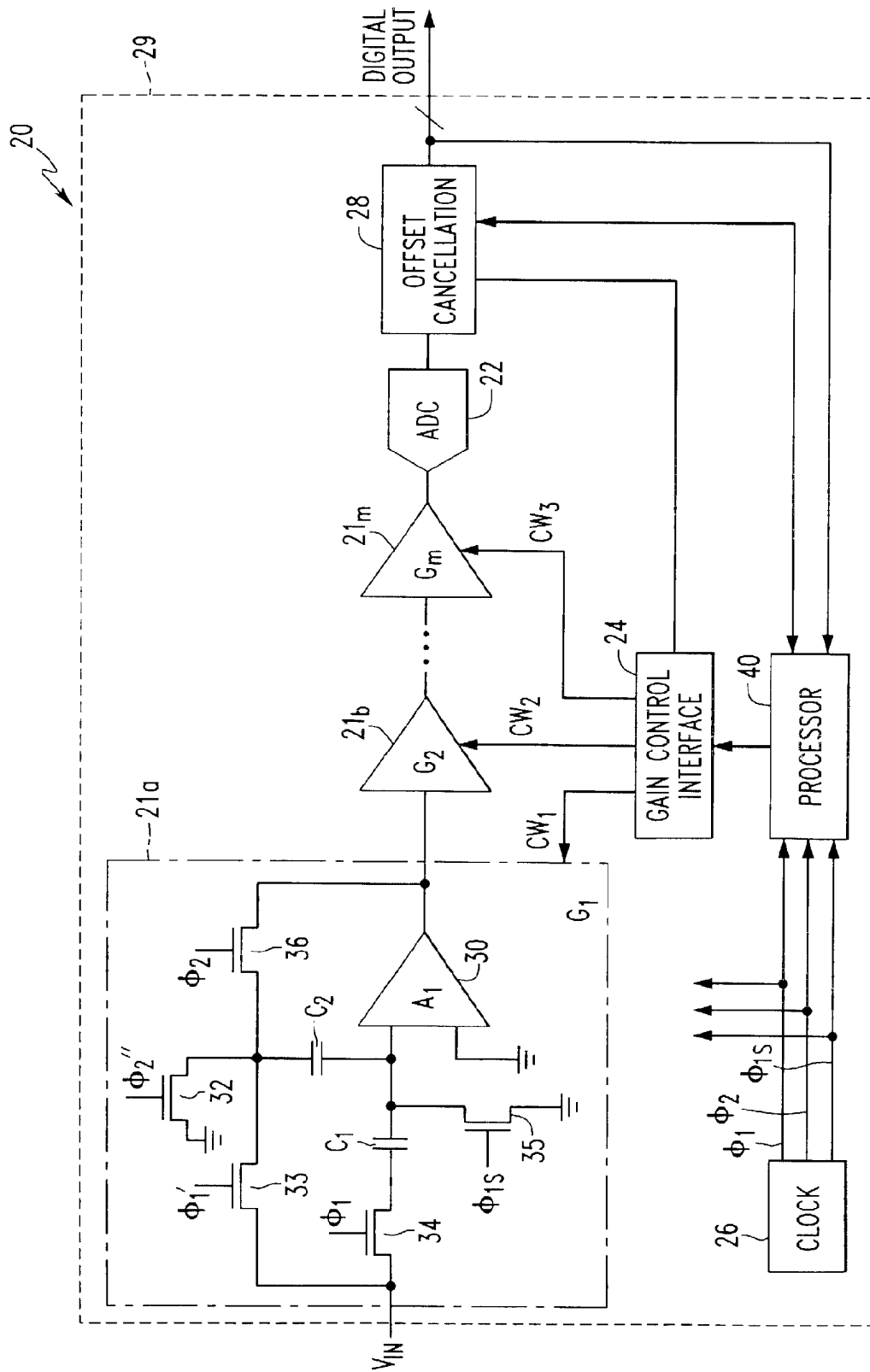
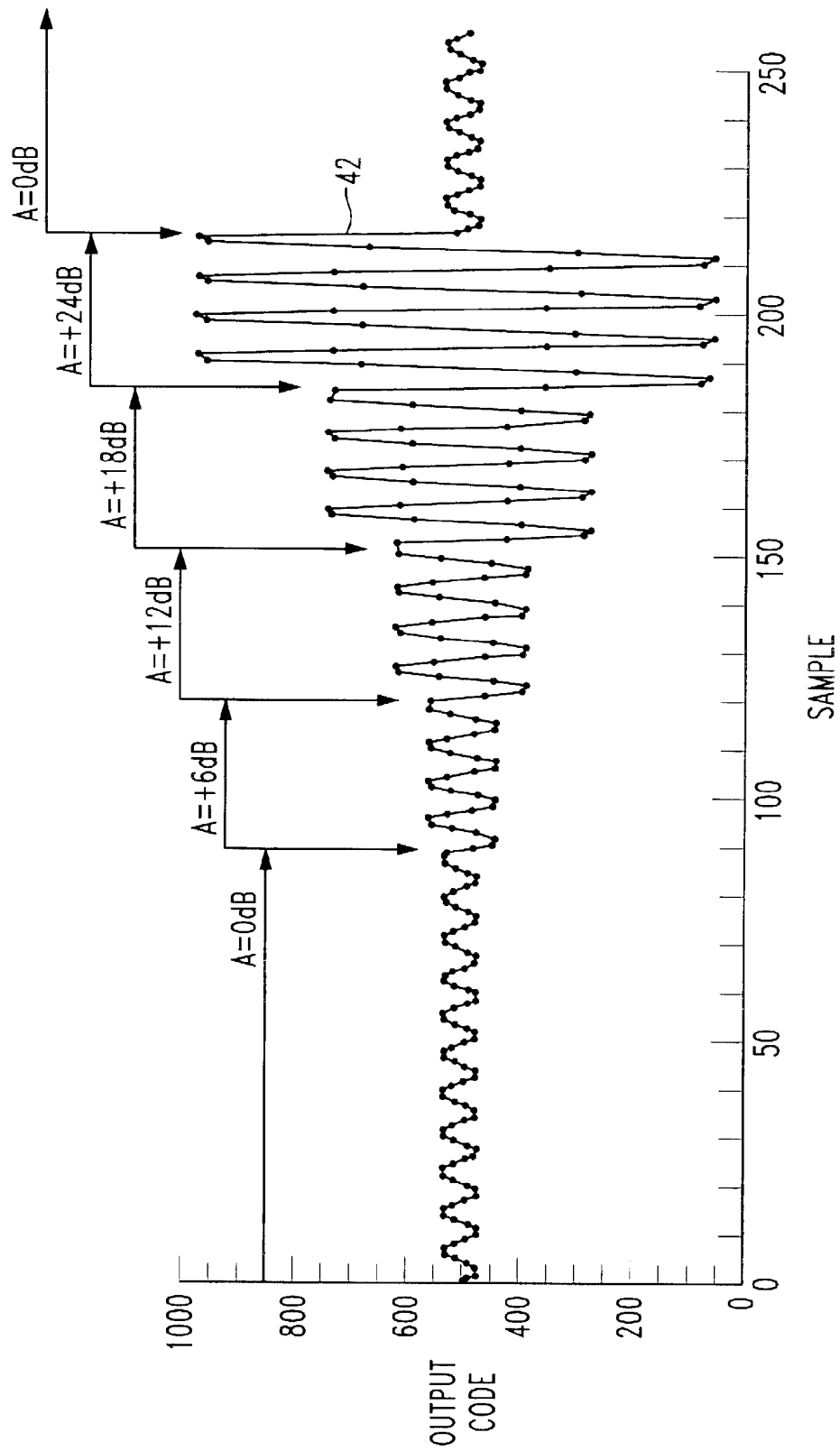


FIG. 5

**FIG. 6**